

Information Disclosure  
Statement by applicant

Applicant(s): K. Geier et al  
 Atty. Docket No: 7239-C2  
 Serial No:  
 Filing Date:  
 Group:

jc997 U.S. PTO  
 10/075456  
 02/15/02

## U. S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Sub- Class	Filing Date if approp.
<i>KE</i>	4,561,731	12/1985	Kley			
	4,682,029	07/1987	Diepeveen et al	250	330	
	4,806,776	02/1989	Kley			
	5,285,196	02/1994	Gale, Jr.			
	5,382,961	01/1995	Gale, Jr.			
	5,444,566	08/1995	Gale, Jr.			
	5,588,948	12/1996	Takahashi et al			
<i>KE</i>	5,748,367	05/1998	Lücke et al	359	375	

## FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	Class	Sub- Class	Trans- lation yes no
<i>KE</i>	0,577,231	05/1933	DE		
	4,236,803	05/1994	DE		
	4,243,556	06/1994	DE		
	4,311,603	10/1994	DE		
	DD290,278	05/1991	DE		
	2,268,283	01/1994	GB		
<i>KE</i>	4-355712	12/1992	JP		

Information Disclosure  
Statement by applicant

Applicant(s): K. Geier et al  
 Atty. Docket No: 7239-C2  
 Serial No:  
 Filing Date:  
 Group:

## FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	Class	Sub- Class	Trans- lation	
					yes	no
<u>0,656,554</u>	<u>06/1995</u>	<u>EP</u>				
<u>0,664,470</u>	<u>07/1995</u>	<u>EP</u>				
<u>0,730,181</u>	<u>09/1996</u>	<u>EP</u>				
<u>WO92/18894</u>	<u>10/1992</u>	<u>WIPO</u>				
<u>WO94/02872</u>	<u>02/1994</u>	<u>WIPO</u>				
<u>WO95/14952</u>	<u>06/1995</u>	<u>WIPO</u>				
<u>WO95/16218</u>	<u>06/1995</u>	<u>WIPO</u>				

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

"Moderne Methoden der Lichtmikroskopie" by G. Göke, Kosmos Verlag, Stuttgart,

1998, pages 312 to 314.

"ABC der Optik", by K. Mütze, Verlag Werner Dausien, Hanau/Main, 1972, pages 142

to 143.

"Novel beam-splitting microscope tube for taking stereo-pairs with full

resolution Nomarski or phase contrast technique, or with epifluorescence"

by R. Wolf, Journal of Microscopy, Vol. 153, February 1989, p. 181 to 186.

Examiner: [Signature]

Date Considered: 2/24/04

Information Disclosure  
Statement by applicant

Applicant(s): K. Geier et al  
Atty. Docket No: 7239-C2  
Serial No:  
Filing Date:  
Group:

jc997 U.S. PRO  
10/075456



U. S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Sub- Class	Filing Date if approp.
---------------------	--------------------	------	------	-------	---------------	------------------------------

<i>cm</i>	5,661,591	08/1997	Lin et al			

FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	Class	Sub- Class	Trans- lation yes no
--------------------	------	---------	-------	---------------	----------------------------


OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

*cm* "Handbuch der Mikroskopie" edited by H. Beyer, VEB Verlag, Berlin, 1977,  
pages 344 and 345.

Examiner: *[Signature]*

Date Considered: *2/24/04*